

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/536,958	<b>Applicant(s)/Patent under Reexamination</b> SHIN ET AL.
	<b>Examiner</b> Teresa J. Walberg	<b>Art Unit</b> 3744

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner